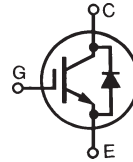


HiPerFAST™ IGBT with Fast Diode

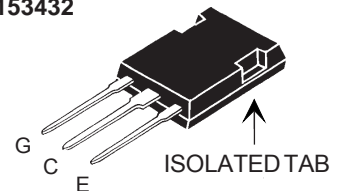
IXGR 50N90B2D1

B2-Class High Speed IGBT with Fast Diode

(Electrically Isolated Back Surface)


$$\begin{aligned} V_{CES} &= 900 \text{ V} \\ I_{C25} &= 40 \text{ A} \\ V_{CE(sat)} &= 2.9 \text{ V} \\ t_{fi typ} &= 200 \text{ ns} \end{aligned}$$

| Symbol | Test Conditions | Maximum Ratings | |
|---|---|-------------------|------------------|
| V_{CES} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}$ | 900 | V |
| V_{CGR} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$ | 900 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ | 40 | A |
| I_{C110} | $T_C = 110^\circ\text{C (IGBT)}$ | 19 | A |
| I_{F110} | $T_C = 110^\circ\text{C (diode)}$ | 22 | A |
| I_{CM} | $T_C = 25^\circ\text{C}, 1 \text{ ms}$ | 200 | A |
| SSOA (RBSOA) | $V_{GE} = 15 \text{ V}, T_{VJ} = 125^\circ\text{C}, R_G = 10 \Omega$ Clamped inductive load @ $\leq 720 \text{ V}$ | $I_{CM} = 100$ | A |
| P_C | $T_C = 25^\circ\text{C}$ | 100 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | | 300 | $^\circ\text{C}$ |
| V_{ISOL} | 50/60 Hz, RMS, $t = 1 \text{ ms}$ | 2500 | V |
| F_C | Mounting force (PLUS247) | 20..120 / 4.5..25 | N/lb |
| Weight | | ISOPLUS247 5 | g |

ISOPLUS247 (IXGR)
E153432


G = Gate C = Collector
E = Emitter TAB = Collector

Features

- Electrically isolated tab
- International standard package outline
- High current handling capability
- MOS Gate turn-on
- Drive simplicity
- Rugged NPT structure
- UL recognized
- Molding epoxies meet UL 94 V-0 flammability classification

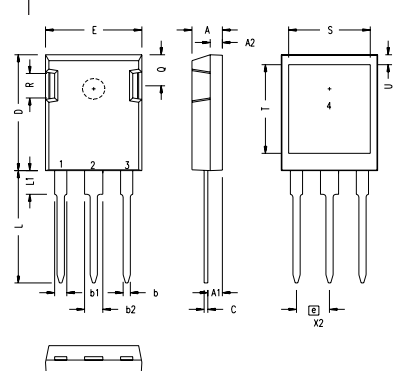
Applications

- Capacitor discharge & pulser circuits
- AC motor speed control
- DC servo and robot drives
- DC choppers
- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$ unless otherwise specified) | Characteristic Values | | |
|---------------|--|-----------------------|------|--------------------------|
| | | Min. | Typ. | Max. |
| $V_{GE(th)}$ | $I_C = 250 \mu\text{A}, V_{CE} = V_{GE}$ | 3.0 | | 5.0 V |
| I_{CES} | $V_{CE} = V_{CES}$ $V_{GE} = 0 \text{ V}$ $T_J = 150^\circ\text{C}$ | | | 50 μA 1 mA |
| I_{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$ | | | $\pm 100 \text{ nA}$ |
| $V_{CE(sat)}$ | $I_C = I_T, V_{GE} = 15 \text{ V}, \text{ Note 1, 2}$ $T_J = 125^\circ\text{C}$ | | 2.2 | 2.9 V |

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$ unless otherwise specified) | Characteristic Values | | |
|--------------|---|-----------------------|------|----------|
| | | Min. | Typ. | Max. |
| g_{fs} | $I_C = I_T; V_{CE} = 10\text{ V, Note 1, 2}$ | 25 | 40 | S |
| C_{ies} | $V_{CE} = 25\text{ V, } V_{GE} = 0\text{ V, } f = 1\text{ MHz}$ | | 2500 | pF |
| C_{oes} | | | 180 | pF |
| C_{res} | | | 75 | pF |
| Q_g | $I_C = I_T, V_{GE} = 15\text{ V, } V_{CE} = 0.5 V_{CES}$ | | 135 | nC |
| Q_{ge} | | | 23 | nC |
| Q_{gc} | | | 50 | nC |
| $t_{d(on)}$ | Inductive load | | 20 | ns |
| t_{ri} | $I_C = I_T, V_{GE} = 15\text{ V}$ | | 28 | ns |
| $t_{d(off)}$ | $V_{CE} = 720\text{ V, } R_G = R_{off} = 5\ \Omega$ | 350 | 500 | ns |
| t_{fi} | Note 2 | | 200 | ns |
| E_{off} | | 4.7 | 7.5 | mJ |
| $t_{d(on)}$ | Inductive load, $T_J = 125^\circ\text{C}$ | | 20 | ns |
| t_{ri} | $I_C = I_T, V_{GE} = 15\text{ V}$ | | 28 | ns |
| E_{on} | $V_{CE} = 720\text{ V, } R_G = R_{off} = 5\ \Omega,$ | | 1.5 | mJ |
| $t_{d(off)}$ | Note 2 | | 400 | ns |
| t_{fi} | | | 420 | ns |
| E_{off} | | | 8.7 | mJ |
| R_{thJC} | | | | 1.25 K/W |
| R_{thCH} | | 0.21 | | K/W |

ISOPLUS247 Outline



| SYM | INCHES | | MILLIMETERS | |
|-----|----------|------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | .190 | .205 | 4.83 | 5.21 |
| A1 | .090 | .100 | 2.29 | 2.54 |
| A2 | .075 | .085 | 1.91 | 2.16 |
| b | .045 | .055 | 1.14 | 1.40 |
| b1 | .075 | .084 | 1.91 | 2.13 |
| b2 | .115 | .123 | 2.92 | 3.12 |
| C | .024 | .031 | 0.61 | 0.80 |
| D | .819 | .840 | 20.80 | 21.34 |
| E | .620 | .635 | 15.75 | 16.13 |
| e | .215 BSC | | 5.45 BSC | |
| L | .780 | .800 | 19.81 | 20.32 |
| L1 | .150 | .170 | 3.81 | 4.32 |
| Q | .220 | .244 | 5.59 | 6.20 |
| R | .170 | .190 | 4.32 | 4.83 |
| S | .520 | .540 | 13.21 | 13.72 |
| T | .620 | .640 | 15.75 | 16.26 |
| U | .065 | .080 | 1.65 | 2.03 |

- 1 - GATE
- 2 - DRAIN (COLLECTOR)
- 3 - SOURCE (EMITTER)
- 4 - NO CONNECTION

NOTE: This drawing will meet all dimensions requirement of JEDEC outline TO-247AD except screw hole.

Diode

| Symbol | Conditions ($T_J = 25^\circ\text{C}$ unless otherwise specified) | Characteristic Values | | |
|------------|---|-----------------------|------|---------|
| | | Min. | Typ. | Max. |
| V_F | $I_F = 30\text{ A; Note 1}$ $T_{VJ} = 150^\circ\text{C}$ | 2.5 | 2.75 | V |
| | | 1.8 | | V |
| I_{RM} | $I_F = I_T, di_F/dt = -100\text{ A}/\mu\text{s; } T_{VJ} = 100^\circ\text{C}$ | 5.5 | 11.5 | A |
| t_{rr} | $V_R = 100\text{ V; } V_{GE} = 0\text{ V}$ | 200 | | ns |
| R_{thJC} | with heat transfer paste | | | 1.1 K/W |
| R_{thCH} | | 0.25 | | K/W |

Note 1: Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$

Note 2: Test Current $I_T = 50\text{ A}$

IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585
 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405B2 6,759,692
 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6771478 B2

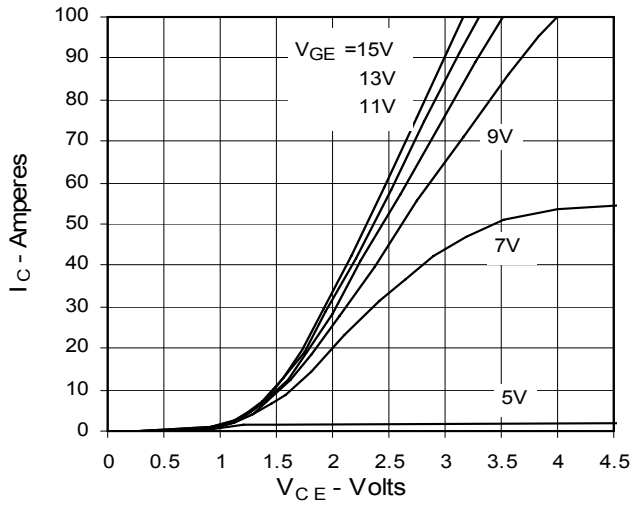
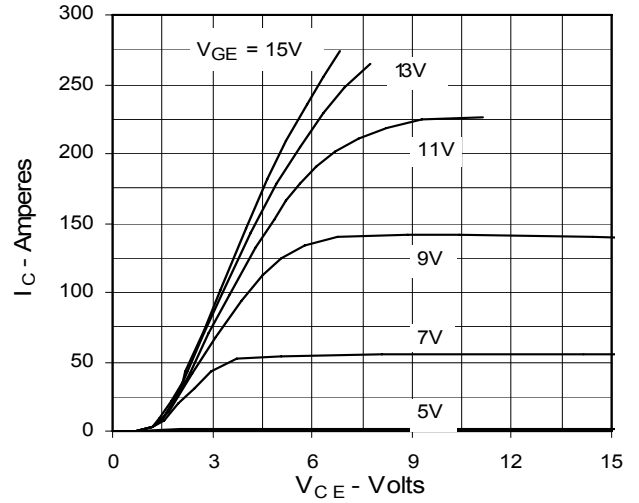
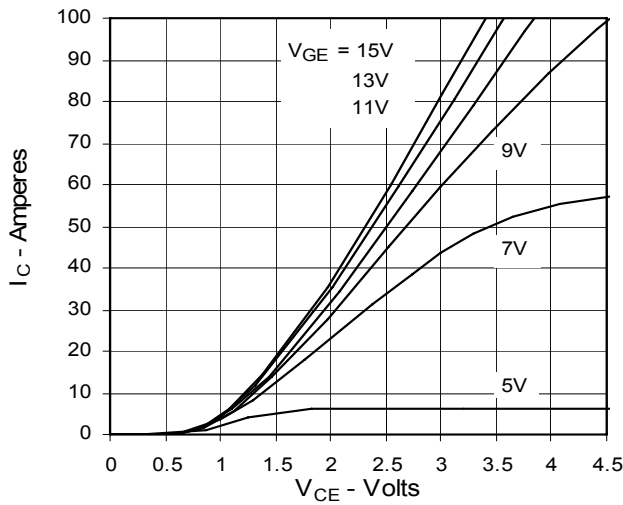
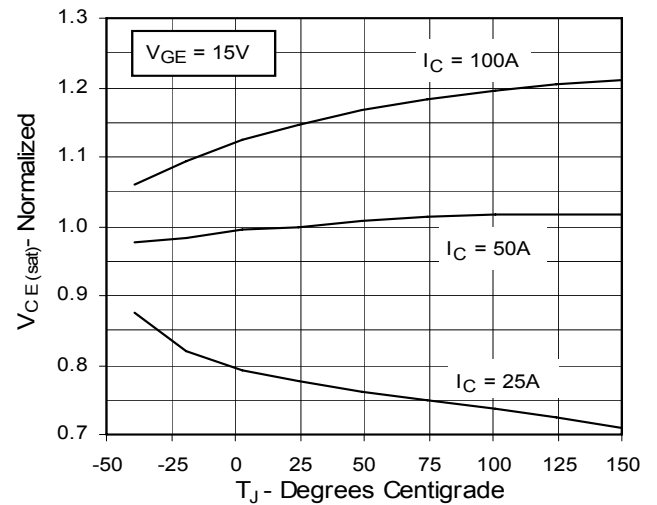
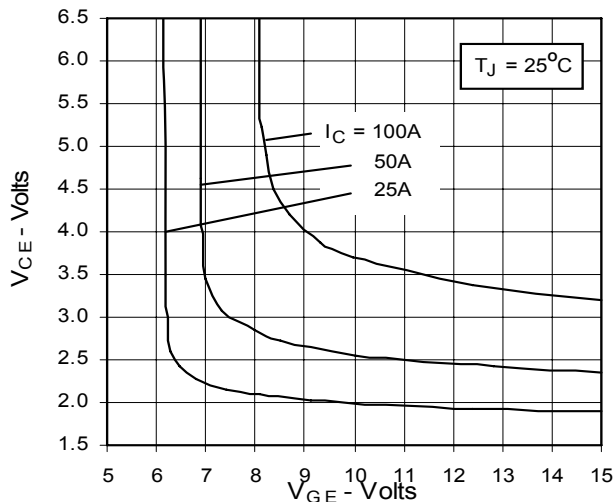
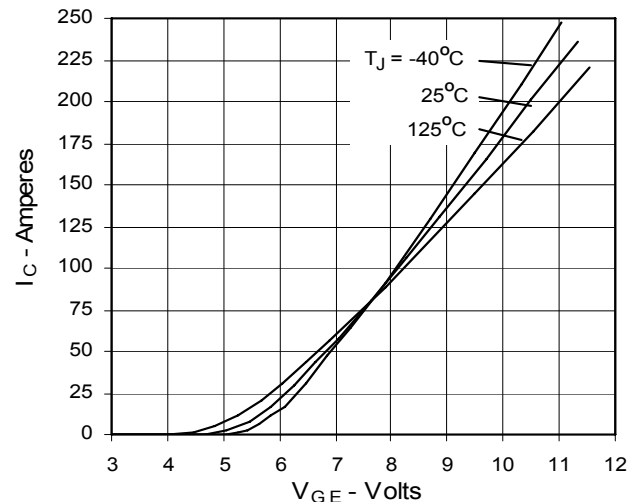
**Fig. 1. Output Characteristics
@ 25 °C**

**Fig. 2. Extended Output Characteristics
@ 25 °C**

**Fig. 3. Output Characteristics
@ 125 °C**

**Fig. 4. Dependence of $V_{CE(sat)}$ on
Temperature**

**Fig. 5. Collector-to-Emitter Voltage
vs. Gate-to-Emitter voltage**

Fig. 6. Input Admittance


Fig. 7. Transconductance

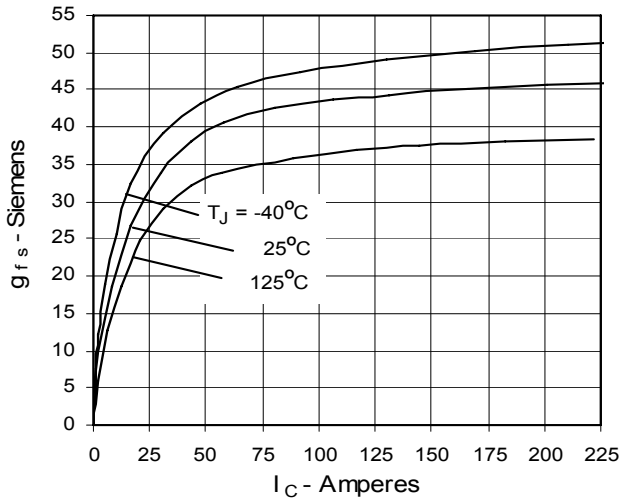


Fig. 8. Dependence of Turn-off Energy Loss on R_G

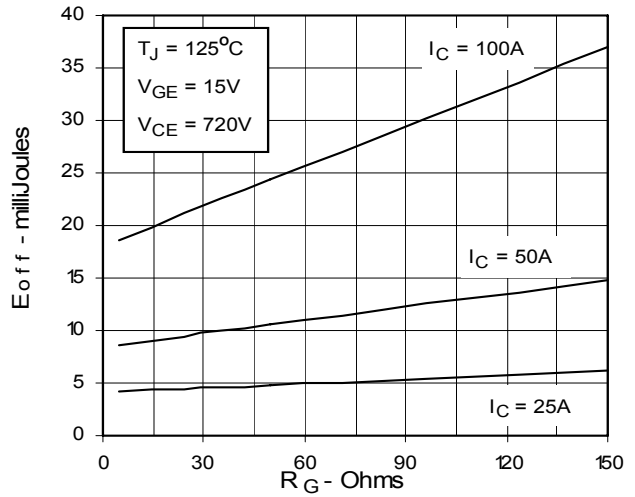


Fig. 9. Dependence of Turn-Off Energy Loss on I_C

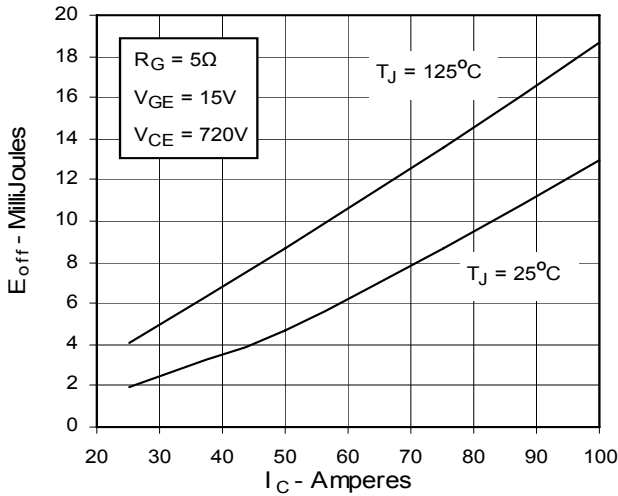


Fig. 10. Dependence of Turn-off Energy Loss on Temperature

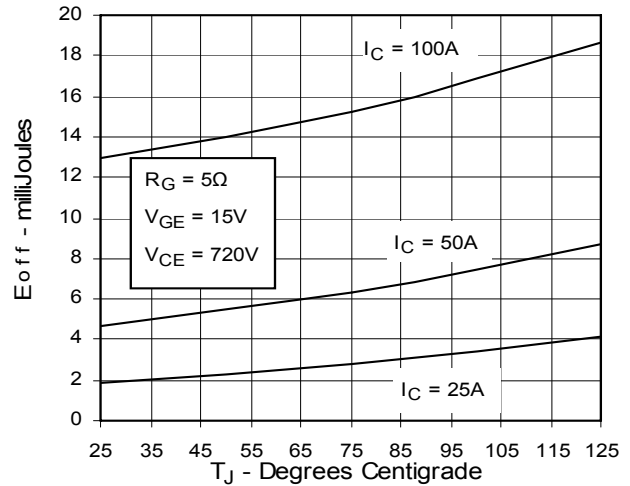


Fig. 11. Dependence of Turn-off Switching Time on R_G

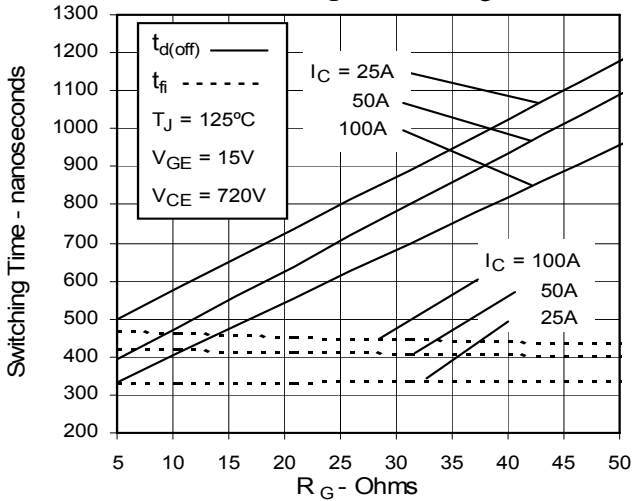


Fig. 12. Dependence of Turn-off Switching Time on I_C

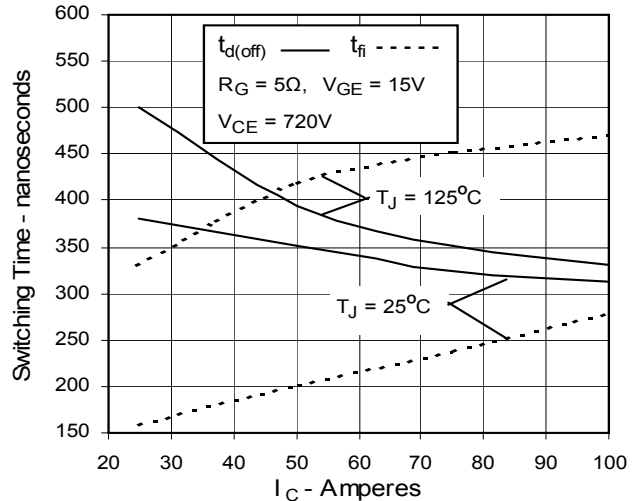


Fig. 13. Dependence of Turn-off Switching Time on Temperature

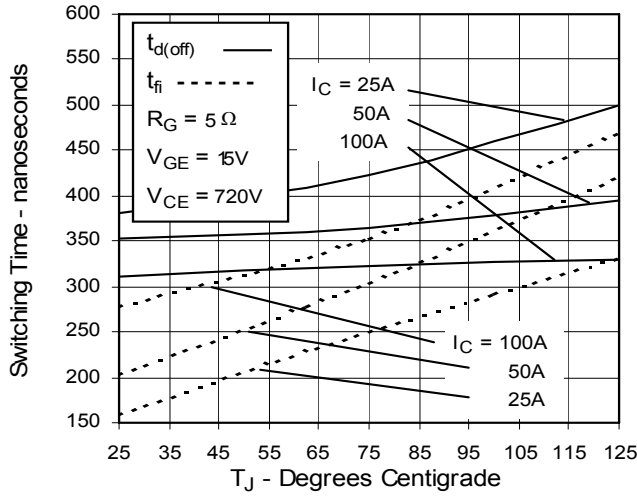


Fig. 14. Gate Charge

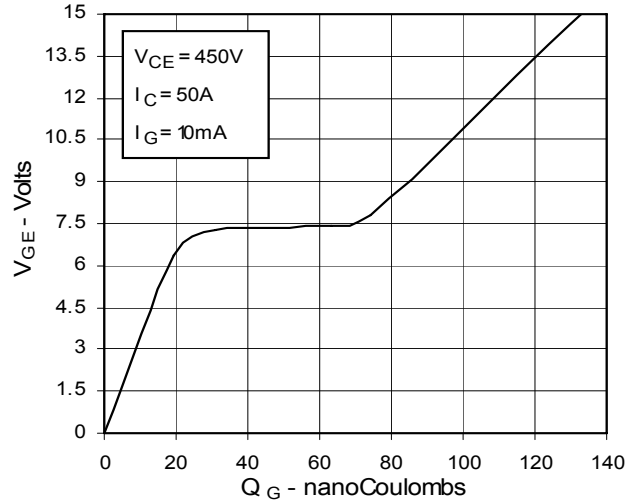


Fig. 15. Capacitance

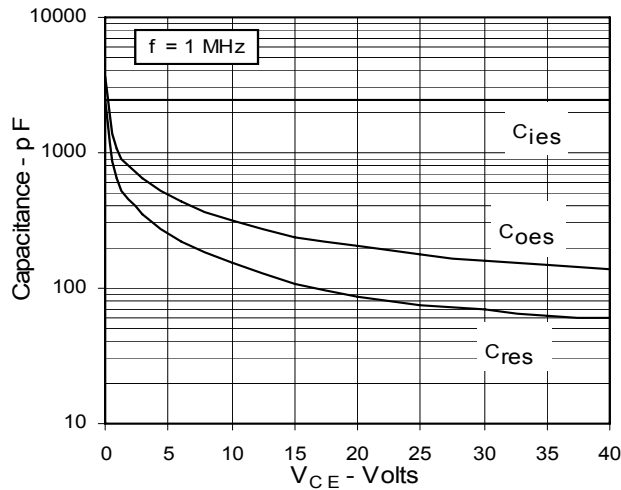


Fig. 16. Reverse-Bias Safe Operating Area

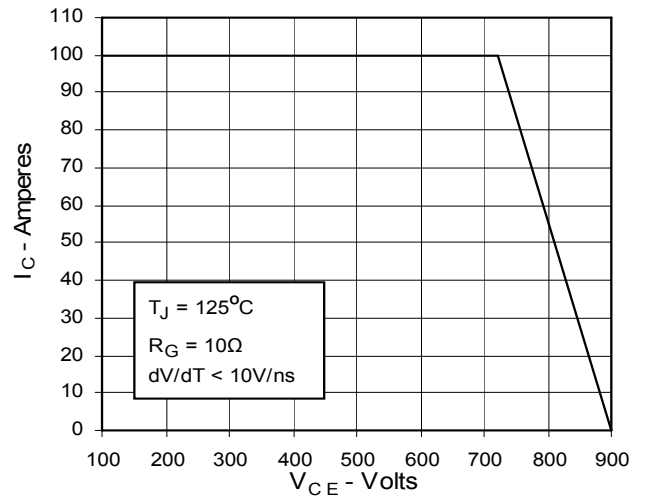
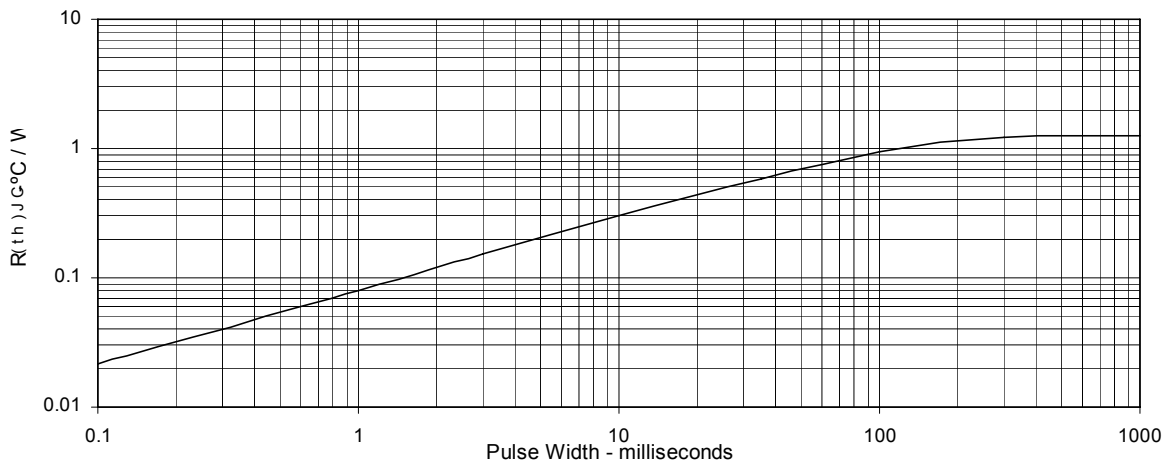


Fig. 17. Maximum Transient Thermal Resistance



Diode Curves

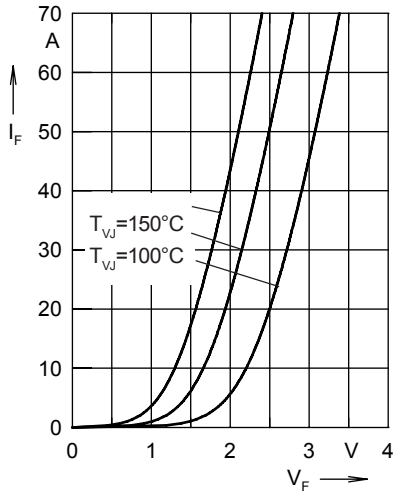


Fig. 18. Forward current I_F versus V_F

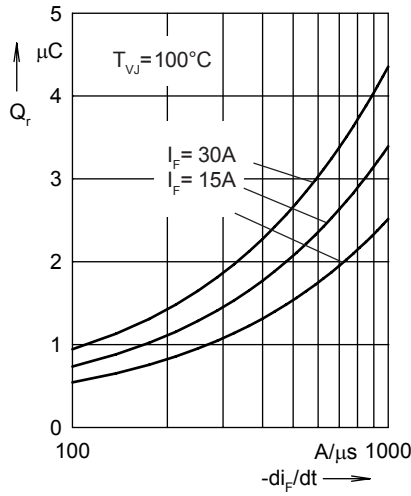


Fig. 19. Reverse recovery charge Q_r

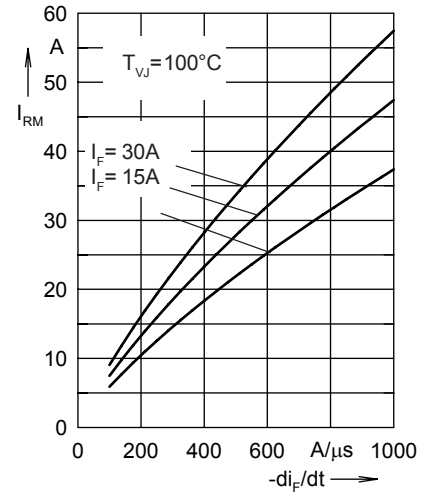


Fig. 20. Peak reverse current I_{RM}

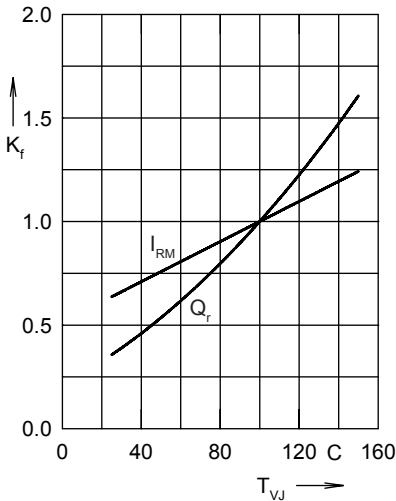


Fig. 21. Dynamic parameters Q_r, I_{RM}

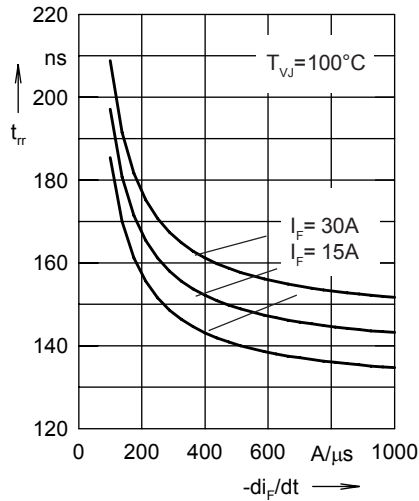


Fig. 22. Recovery time t_{tr} versus $-di_F/dt$

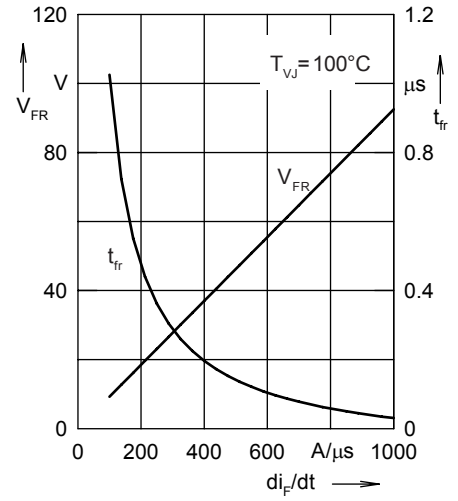


Fig. 23. Peak forward voltage V_{FR} and t_{tr}

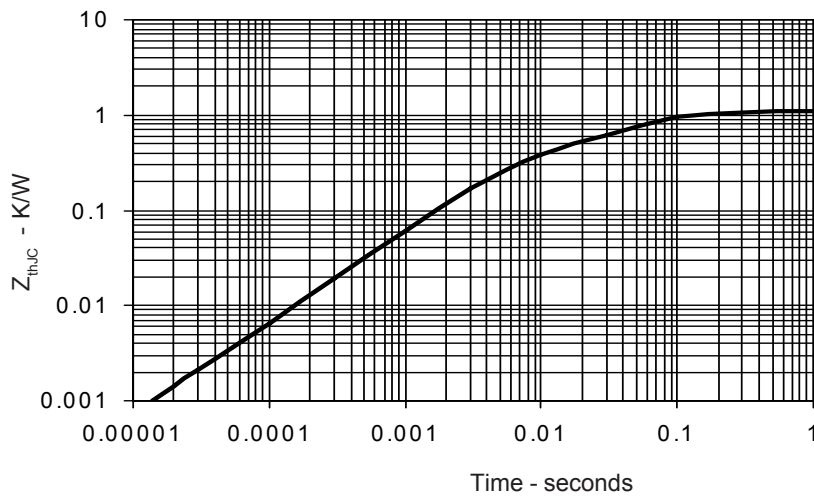


Fig. 24. Transient thermal resistance junction to case